

<b>Notice of References Cited</b>	Application/Control No. 10/622,378	Applicant(s)/Patent Under Reexamination MUKERJEE ET AL.	
	Examiner Nhon T. Diep	Art Unit 2621	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,362,807	04-2008	Kondo et al.	375/240.16
*	B	US-2004/0139462	07-2004	Hannuksela et al.	725/032
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

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